Notice of References Cited Application/Control No. 10/713,508 Applicant(s)/Patent Under Reexamination LIN, WEN-JIAN Examiner John A. McPherson 1756 Applicant(s)/Patent Under Reexamination LIN, WEN-JIAN Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0218251	11-2004	Piehl et al.	359/290
*	В	US-2004/0209192	10-2004	Lin et al.	430/311
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	н	US-			
	1	US-			
	٦	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т				_	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	>						
	>						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.